

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/015,164	LEE	
Examiner	Art Unit	
Susanna M. Diaz	3694	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted Business Practice Specialist Bob Weinhardt Re: restriction	3/27/2007	SMD		
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